

# SAR Evaluation Report

**Application No.:** SZEM2006005017CR  
**Applicant:** Shenzhen Bason Electronics Technology Co., Ltd.  
**Address of Applicant:** 5th Floor, B Building, Huilongda Industrial Park, Shuitian Community, Shiyan Street, Baoan District Shenzhen.  
**Manufacturer:** Shenzhen Bason Electronics Technology Co., Ltd.  
**Address of Manufacturer:** 5th Floor, B Building, Huilongda Industrial Park, Shuitian Community, Shiyan Street, Baoan District Shenzhen.  
**Factory:** Shenzhen Bason Electronics Technology Co., Ltd.  
**Address of Factory:** 5th Floor, B Building, Huilongda Industrial Park, Shuitian Community, Shiyan Street, Baoan District Shenzhen.

**Equipment Under Test (EUT):**

**EUT Name:** LED strip  
**Model No.:** 10M36W114B  
**FCC ID:** 2AVYG-E114B  
**Standards:** 47 CFR Part 1.1307 (2016)  
47 CFR Part 2.1093 (2016)  
KDB447498D01 General RF Exposure Guidance v06

**Date of Receipt:** 2020-06-16  
**Date of Test:** 2020-10-26 to 2020-12-18  
**Date of Issue:** 2020-12-29

<b>Test Result :</b>	<b>Pass*</b>
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\* In the configuration tested, the EUT complied with the standards specified above.

Keny Xu  
EMC Laboratory Manager



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**Attention: To check the authenticity of testing /inspection report & certificate, please contact us at telephone: (86-755) 8307 1443, or email: CN.Doccheck@sgs.com**

## 2 Version

Revision Record				
Version	Chapter	Date	Modifier	Remark
01		2020-12-29		Original

Authorized for issue by:			
			
		<hr/> <b>Peter Geng /Project Engineer</b>	
			
		<hr/> <b>Eric Fu /Reviewer</b>	





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## 4 General Information

### 4.1 General Description of EUT

Power Supply:	AC/DC adapter information, MODEL: MYX-2401000US INPUT: AC 100-240V, 50/60Hz, 0.8A Max OUTPUT: DC 24V, 1A
Cable:	DC line: 150cm, unshielded
Antenna Gain:	-3 dBi
Antenna Type:	Integral antenna
Channel Spacing:	2MHz
Modulation Type:	GFSK
Number of Channels:	40
Operation Frequency:	2402MHz to 2480MHz



## 4.2 Test Location

All tests were performed at:

SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch

No. 1 Workshop, M-10, Middle section, Science & Technology Park, Shenzhen, Guangdong, China  
518057

Telephone: +86 (0) 755 2601 2053 Fax: +86 (0) 755 2671 0594

No tests were sub-contracted.

## 4.3 Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

- **A2LA (Certificate No. 3816.01)**

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory is accredited by the American Association for Laboratory Accreditation(A2LA). Certificate No. 3816.01.

- **VCCI**

The 3m Fully-anechoic chamber for above 1GHz, 10m Semi-anechoic chamber for below 1GHz, Shielded Room for Mains Port Conducted Interference Measurement and Telecommunication Port Conducted Interference Measurement of SGS-CSTC Standards Technical Services Co., Ltd. have been registered in accordance with the Regulations for Voluntary Control Measures with Registration No.: G-20026, R-14188, C-12383 and T-11153 respectively.

- **FCC –Designation Number: CN1178**

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory has been recognized as an accredited testing laboratory.

Designation Number: CN1178. Test Firm Registration Number: 406779.

- **Innovation, Science and Economic Development Canada**

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory has been recognized by ISED as an accredited testing laboratory.

CAB identifier: CN0006.

IC#: 4620C.

## 4.4 Deviation from Standards

None.

## 4.5 Abnormalities from Standard Conditions

None.

## 4.6 Other Information Requested by the Customer

None.





## 5 SAR Evaluation

### 5.1 RF Exposure Compliance Requirement

#### 5.1.1 Standard Requirement

According to KDB447498D01 General RF Exposure Guidance v06

##### 4.3.1. Standalone SAR test exclusion considerations

Unless specifically required by the published RF exposure KDB procedures, standalone 1-g head or body and 10-g extremity SAR evaluation for general population exposure conditions, by measurement or numerical simulation, is not required when the corresponding SAR Exclusion Threshold condition, listed below, is satisfied.

#### 5.1.2 Limits

The 1-g and 10-g SAR test exclusion thresholds for 100 MHz to 6 GHz at test separation distances  $\leq 50$  mm are determined by:

$[(\text{max. power of channel, including tune-up tolerance, mW}) / (\text{min. test separation distance, mm})] \cdot [\sqrt{f(\text{GHz})}] \leq 3.0$  for 1-g SAR and  $\leq 7.5$  for 10-g extremity SAR, where

$f(\text{GHz})$  is the RF channel transmit frequency in GHz

Power and distance are rounded to the nearest mW and mm before calculation<sup>17</sup>

The result is rounded to one decimal place for comparison

The test exclusions are applicable only when the minimum test separation distance is  $\leq 50$  mm and for transmission frequencies between 100 MHz and 6 GHz. When the minimum test separation distance is  $< 5$  mm, a distance of 5 mm is applied to determine SAR test exclusion

#### 5.1.3 EUT RF Exposure

The Max. power (including tune-up tolerance) -2.53 dBm on the highest channel 2.44 GHz (\*)  
 -2.53 dBm logarithmic terms convert to numeric result is nearly 0.56 mW

According to the formula, calculate the test exclusion thresholds:

$[(\text{max. power of channel, including tune-up tolerance, mW}) / (\text{min. test separation distance, mm})] \cdot [\sqrt{f(\text{GHz})}]$

$$\text{General RF Exposure} = (0.56 \text{ mW} / 5 \text{ mm}) \times \sqrt{2.44 \text{ GHz}} = 0.17 \quad (1)$$

SAR requirement:

$$S = 3.0 \quad (2)$$

(1) < (2)

So the SAR report is not required.

(\*) Max. power refer to Report No.:SZEM200600501702

- End of the Report -

